



**PATENT**

**IN THE UNITED STATES PATENT AND TRADEMARK OFFICE**

**In re Application of:**

Rodney L. Kirstine

**Serial No.:** 10/642,921

**Filed:** August 18, 2003

**For:** METHOD AND APPARATUS FOR  
MEASUREMENT OF THICKNESS AND  
WARPAGE OF SUBSTRATES

**Confirmation No.:** 3659

**Examiner:** Y. Guadalupe

**Group Art Unit:** 2859

**Attorney Docket No.:** 2269-5659US  
(02-1364.00/US)

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**AMENDMENT ACCOMPANYING RCE**

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Commissioner for Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450

Sir:

The following amendments and remarks are filed in response to the Examiner's remarks in the Final Office Action mailed February 4, 2005 and the Advisory Action mailed April 25, 2005. The present Amendment is filed within the three-month shortened statutory period for response in conjunction with a Request for Continued Examination and the required fee.

**Amendments to the Claims** are reflected in the listing of claims which begins on page 2 of this paper.

**Remarks/Arguments** begin on page 10 of this paper.